FLAT-BASE TYPE INSULATED PACKAGE

#### PM200RL1A060



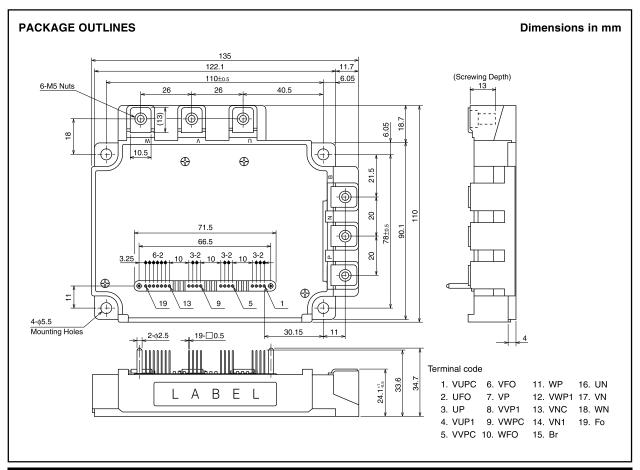
#### **FEATURE**

Inverter + Brake + Drive & Protection IC

- a) Adopting new 5th generation Full-Gate CSTBT<sup>TM</sup> chip
- b) The over-temperature protection which detects the chip surface temperature of  $\mathsf{CSTBT^{TM}}$  is adopted.
- c) Error output signal is possible from all each protection upper and lower arm of IPM.
- d) Compatible L-series package.
  - 3φ 200A, 600V Current-sense and temperature sense IGBT type inverter
  - Monolithic gate drive & protection logic
  - Detection, protection & status indication circuits for, shortcircuit, over-temperature & under-voltage (P-Fo available from upper arm devices)
  - UL Recognized

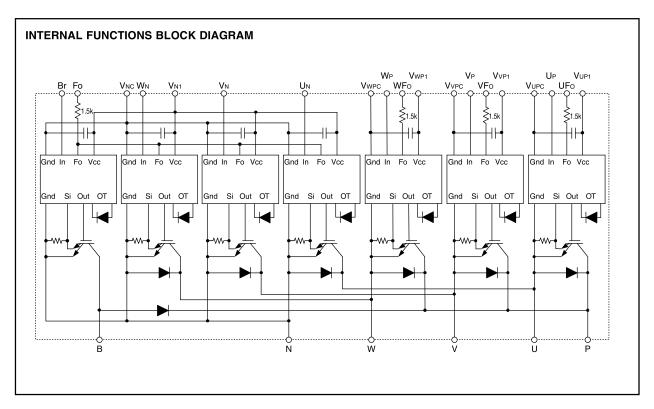
#### **APPLICATION**

General purpose inverter, servo drives and other motor controls





FLAT-BASE TYPE INSULATED PACKAGE



#### **MAXIMUM RATINGS** (Tj = 25°C, unless otherwise noted)

### **INVERTER PART**

Symbol	Parameter	Condition	Ratings	Unit
VCES	Collector-Emitter Voltage	VD = 15V, VCIN = 15V	600	٧
±ΙC	Collector Current	$Tc = 25^{\circ}C$ (Note-1)	200	Α
±ICP	Collector Current (Peak)	Tc = 25°C	400	Α
Pc	Collector Dissipation	$Tc = 25^{\circ}C$ (Note-1)	625	W
Tj	Junction Temperature		<b>−20</b> ~ +150	°C

<sup>\*:</sup> Tc measurement point is just under the chip.

#### **BRAKE PART**

Symbol	Parameter	Condition	Ratings	Unit
VCES	Collector-Emitter Voltage	VD = 15V, VCIN = 15V	600	V
Ic	Collector Current	$Tc = 25^{\circ}C$ (Note-1)	100	Α
ICP	Collector Current (Peak)	Tc = 25°C	200	Α
Pc	Collector Dissipation	$Tc = 25^{\circ}C$ (Note-1)	390	W
lF	FWDi Forward Current	Tc = 25°C	100	Α
VR(DC)	FWDi Rated DC Reverse Voltage	Tc = 25°C	600	V
Tj	Junction Temperature		<b>−20</b> ~ +150	°C

#### **CONTROL PART**

Symbol	Parameter	Condition	Ratings	Unit
VD	Supply Voltage	Applied between: VuP1-VuPc, VvP1-VvPc VwP1-VwPc, Vn1-Vnc	20	V
VCIN	Input Voltage	Applied between : UP-VUPC, VP-VVPC, WP-VWPC UN • VN • WN • Br-VNC	20	V
VFO	Fault Output Supply Voltage	Applied between : UFO-VUPC, VFO-VVPC, WFO-VWPC FO-VNC	20	V
IFO	Fault Output Current	Sink current at UFO, VFO, WFO, FO terminals	20	mA



# FLAT-BASE TYPE INSULATED PACKAGE

#### TOTAL SYSTEM

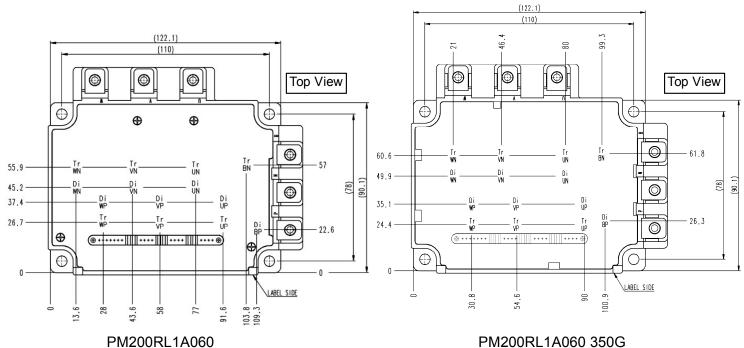
Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CC(PROT)</sub>	Supply Voltage Protected by SC	$V_D$ =13.5V ~ 16.5V Inverter Part, $T_j$ =+125°C Start	400	V
V <sub>CC(surge)</sub>	Supply Voltage (Surge)	Applied between : P-N, Surge value	500	V
T <sub>stg</sub>	Storage Temperature		-40 ~ +125	°C
V <sub>iso</sub>	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

<sup>\*:</sup> T<sub>C</sub> measurement point is just under the chip.

#### THERMAL RESISTANCE

Symbol	Parameter	Conditions		Limits		
Symbol	i arameter			Тур.	Max.	Unit
R <sub>th(j-c)Q</sub>	Thermal Resistance	Inverter, IGBT (per 1 element) (Note.1)	-	-	0.20	
R <sub>th(j-c)F</sub>		Inverter, FWDi (per 1 element) (Note.1)	-	-	0.30	
R <sub>th(j-c)Q</sub>		Brake, IGBT (Note.1)	-	-	0.32	°C/W
R <sub>th(j-c)F</sub>		Brake, FwDi upper part (Note.1)	-	-	0.53	] C/VV
R <sub>th(c-f)</sub>	Contact Thermal Resistance	Case to fin, (per 1 module) Thermal grease applied (Note.1)	-	-	0.023	

Note.1: If you use this value, R<sub>th(f-a)</sub> should be measured just under the chips.



### PM200RL1A060 350G

\* "350G" is printed on the label

# **ELECTRICAL CHARACTERISTICS** (Tj = 25°C, unless otherwise noted)

#### **INVERTER PART**

Symbol	Parameter	Conditions		Limits			Unit
Syllibol	Falailletei	Conditions		Min.	Тур.	Max.	Offic
V	Collector-Emitter Saturation	V <sub>D</sub> =15V, I <sub>C</sub> =200A	T <sub>j</sub> =25°C	-	1.75	2.35	V
V <sub>CE(sat)</sub>	Voltage	V <sub>CIN</sub> =0V, Pulsed (Fig. 1)	T <sub>j</sub> =125°C	-	1.75	2.35	\ \
V <sub>EC</sub>	FwDi Forward Voltage	-I <sub>C</sub> =200A, V <sub>D</sub> =15V, V <sub>CIN</sub> = 15V	(Fig. 2)	-	1.7	2.8	V
t <sub>on</sub>				0.3	0.8	2.0	
t <sub>rr</sub>		$V_D=15V$ , $V_{CIN}=0V \longleftrightarrow 15V$		-	0.4	0.8	
t <sub>c(on)</sub>	Switching Time	V <sub>CC</sub> =300V, I <sub>C</sub> =200A T <sub>i</sub> =125°C		-	0.4	1.0	μS
t <sub>off</sub>		Inductive Load	(Fig. 3,4)	-	1.0	2.3	
$t_{c(off)}$			(* 131 = 7, 1)	-	0.3	1.0	
1	Collector-Emitter Cut-off	V <sub>CE</sub> =V <sub>CES</sub> , V <sub>D</sub> =15V , V <sub>CIN</sub> =15V (Fig. 5)	T <sub>j</sub> =25°C	-	-	1	mA
I <sub>CES</sub>	Current	VCE-VCES, VD-13V, VCIN-13V (FIG. 5)	T <sub>j</sub> =125°C	-	-	10	IIIA



FLAT-BASE TYPE INSULATED PACKAGE

#### **BRAKE PART**

0	D	Condition		Limits			1114
Symbol	symbol Parameter Condition			Min.	Тур.	Max.	Unit
	Collector-Emitter Saturation	VD = 15V, IC = 100A	Tj = 25°C	_	1.75	2.35	V
VCE(sat)	Voltage	VCIN = 0V, Pulsed (Fig. 1)	Tj = 125°C	_	1.75	2.35	v
VEC	FWDi Forward Voltage	-IC = 100A, VCIN = 15V, VD = 15V	(Fig. 2)	_	1.7	2.8	V
ICES	Collector-Emitter Cutoff	VcE = VcEs, VD = 15V (Fig. 5)	Tj = 25°C	_	_	1	A
	Current	VCE = VCES, VD = 15V (Fig. 5)	Tj = 125°C	_	_	10	mA

#### **CONTROL PART**

Cumahal	Damanatan	O and the an	Condition		Limits		
Symbol	Parameter	Condition			Тур.	Max.	Unit
ID	Circuit Current	VD = 15V, VCIN = 15V	Vn1-Vnc	_	8	16	mΛ
10	Circuit Current	VD = 13V, VCIN = 13V	V*P1-V*PC	_	2	4	mA
Vth(ON)	Input ON Threshold Voltage	Applied between : UP-VUPC, VP-VVPC,	WP-VWPC	1.2	1.5	1.8	V
Vth(OFF)	Input OFF Threshold Voltage	Un • Vn • Wn • Br-Vn	1C	1.7	2.0	2.3	V
sc	Object Object Trie Level	$-20 \le T_i \le 125^{\circ}C$ , $VD = 15V$ (Fig. 3.6)	Inverter part	400	_	_	Λ.
30	Short Circuit Trip Level	$ -20 \le 1] \le 125 \text{ C}, \text{ VD} = 15 \text{ V} \text{ (Fig. 3.6)}$	Brake part	200	_	_	Α
toff(SC)	Short Circuit Current Delay Time	VD = 15V	(Fig. 3,6)	_	0.2	_	μs
ОТ	Over Temperature Protection	Detect Temperature of IGBT chip	Trip level	135	_	_	°C
OT(hys)	Over remperature Protection		Hysteresis	_	20	_	
UV	Supply Circuit Under-Voltage	–20 ≤ T <sub>i</sub> ≤ 125°C	Trip level	11.5	12.0	12.5	V
UVr	Protection	-20 ± 1j ± 125 C	Reset level	_	12.5	_	v
IFO(H)	Fault Output Current	VD = 15V, VCIN = 15V	(Note-2)	_	_	0.01	mA
IFO(L)		VD = 15V, VCIN = 15V	(14016-2)	_	10	15	ША
tFO	Minimum Fault Output Pulse Width	VD = 15V	(Note-2)	1.0	1.8	_	ms

(Note-2) Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

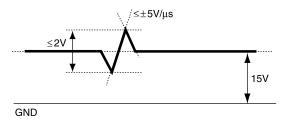
#### **MECHANICAL RATINGS AND CHARACTERISTICS**

	Condition		Limits			Unit	
Symbol	Parameter	Condition		Min.	Тур.	Max.	Unit
	Mounting torque	Mounting part screw	: M5	2.5	3.0	3.5	N•m
	Mounting torque	Main terminal part screw	: M5	2.5	3.0	3.5	N•m
_	Weight	_		_	800	_	g

#### **RECOMMENDED CONDITIONS FOR USE**

Symbol	Parameter	Condition	Recommended value	Unit
Vcc	Supply Voltage	Applied across P-N terminals	≤ 400	V
VD	Control Supply Voltage	Applied between : VuP1-VuPC, VvP1-VvPC VWP1-VWPC, VN1-VNC (Note-3)	15.0 ± 1.5	<b>V</b>
VCIN(ON)	Input ON Voltage	Applied between: UP-VuPc, VP-VvPc, WP-VwPc	≤ 0.8	\ \
VCIN(OFF)	Input OFF Voltage	Un • Vn • Wn • Br-Vnc	≥ 9.0	V
fPWM	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
tdead	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 2.0	μs

(Note-3) With ripple satisfying the following conditions: dv/dt swing  $\leq \pm 5V/\mu s$ , Variation  $\leq 2V$  peak to peak



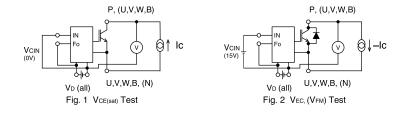


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#### PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (VD), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state. After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above VCES rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)



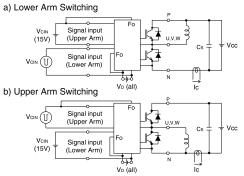


Fig. 3 Switching time and SC test circuit

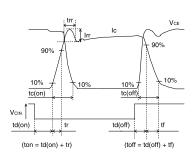


Fig. 4 Switching time test waveform

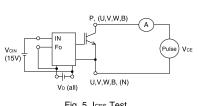


Fig. 5 Ices Test

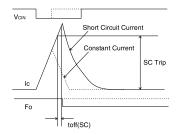
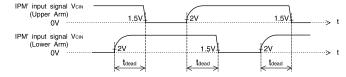


Fig. 6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead time measurement point example



FLAT-BASE TYPE INSULATED PACKAGE

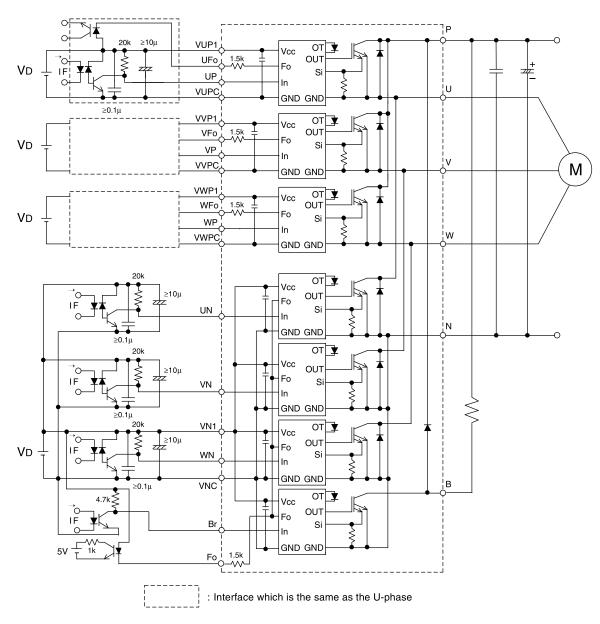


Fig. 8 Application Example Circuit

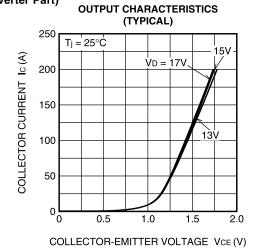
#### NOTES FOR STABLE AND SAFE OPERATION;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: tPLH, tPHL ≤ 0.8μs, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- •Use 4 isolated control power supplies (VD). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.
- Use line noise filter capacitor (ex. 4.7nF) between each input AC line and ground to reject common-mode noise from AC line and improve noise immunity of the system.

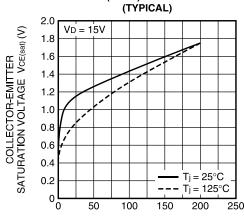


FLAT-BASE TYPE INSULATED PACKAGE

# PERFORMANCE CURVES (Inverter Part)

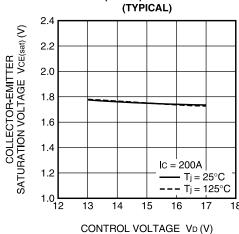


COLLECTOR-EMITTER SATURATION
VOLTAGE (VS. Ic) CHARACTERISTICS

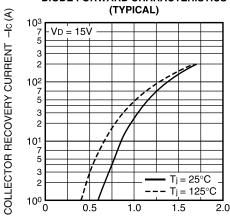


COLLECTOR CURRENT Ic (A)

#### COLLECTOR-EMITTER SATURATION VOLTAGE (VS. VD) CHARACTERISTICS (TYPICAL)

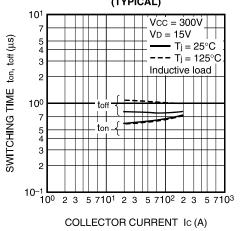


# DIODE FORWARD CHARACTERISTICS

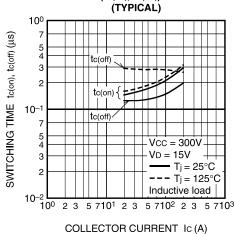


EMITTER-COLLECTOR VOLTAGE VEC (V)

# SWITCHING TIME (ton, toff) CHARACTERISTICS (TYPICAL)



# SWITCHING TIME (tc(on), tc(off)) CHARACTERISTICS

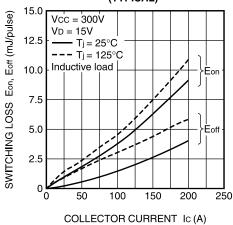


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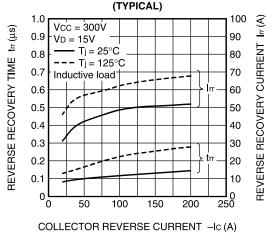


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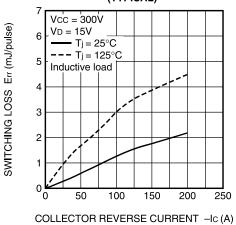
# SWITCHING LOSS CHARACTERISTICS (TYPICAL)



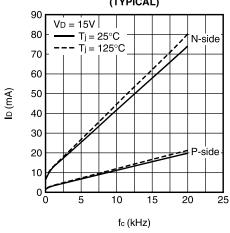
# DIODE REVERSE RECOVERY CHARACTERISTICS



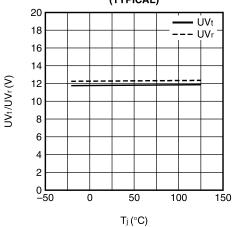
# SWITCHING RECOVERY LOSS CHARACTERISTICS (TYPICAL)



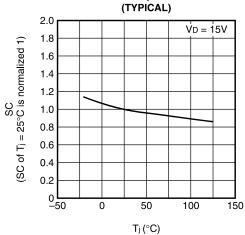
# ID VS. fc CHARACTERISTICS (TYPICAL)



# UV TRIP LEVEL VS. Tj CHARACTERISTICS (TYPICAL)

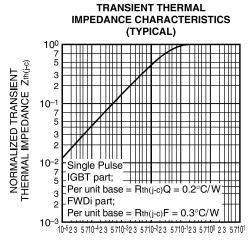


### SC TRIP LEVEL VS. Tj CHARACTERISTICS





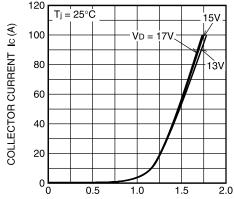
**FLAT-BASE TYPE INSULATED PACKAGE** 



TIME t (sec)

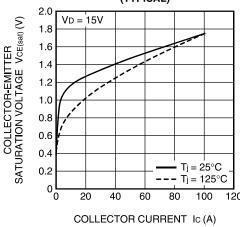
### **OUTPUT CHARACTERISTICS** (TYPICAL) 120 Tj = 25°C

(Brake Part)

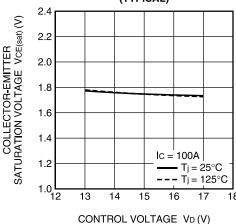


COLLECTOR-EMITTER VOLTAGE VCE (V)

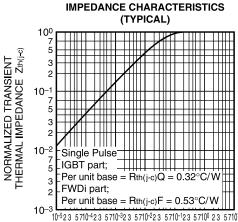
#### **COLLECTOR-EMITTER SATURATION VOLTAGE (VS. Ic) CHARACTERISTICS** (TYPICAL)



**COLLECTOR-EMITTER SATURATION VOLTAGE (VS. VD) CHARACTERISTICS** (TYPICAL)

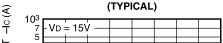


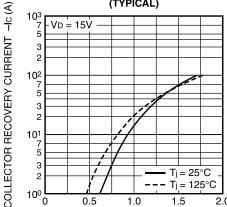
**DIODE FORWARD CHARACTERISTICS** 



TIME t (sec)

TRANSIENT THERMAL





EMITTER-COLLECTOR VOLTAGE VEC (V)



November 2012

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